

Search Notes

Application/Control No.

10/621,755

Examiner

Leila Malek

Applicant(s)/Patent under
Reexamination

HAN, KE

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	362	11/3/2006	L.M
375	354	11/3/2006	L.M
360	39	11/3/2006	L.M

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/3/2006	L.M
IEEE	11/3/2006	L.M
GOOGLE	11/3/2006	L.M
Consulted M. Ghayour	11/3/2006	L.M
Consulted D, Davidson	11/3/2006	L.M
Consulted M. Slavitt	11/3/2006	L.M
Consulted R. Eisenzopf	11/8/2006	L.M
PLUS search	11/6/2006	L.M